


<b>Search Notes</b>  	<b>Application/Control No.</b>  10628822	<b>Applicant(s)/Patent Under Reexamination</b>  WALKER ET AL.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
370	323, 334	10/31/2006	Siu M. Lee
710	38	10/31/2006	Siu M. lee
455	3.01,3.02,3.03,3.04,7,427,428,12.1,181.1,171.1,178.1,186,191.1,456.1,457,414.1,161.2,161.3,166.2,184.1,419,345	10/31/2006	Siu M. Lee
710	38	4/27/2007	Siu M. Lee
375	132-137	4/27/2007	Siu M. Lee
455	3.01,7,427,3.02,3.03,428,12.1,3.04,3.06,556,181.1,171.1,178.1,186.1,191.1,193.1,193.2,132,184,187,456.1,457,414.1,419,345,456.3,20,74,18,66,45,6.3,4.1,4.2,103	4/27/2007	Siu M. Lee
370	316,330,478,132,328,329,335-338,340-342	4/27/2007	Siu M. Lee

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	10/25/2006	Siu M. Lee
consult primary examiner of 370 (John Pezzlo)	10/27/2006	Siu M. Lee
Discuss the application with SPE (Chieh Fan)	10/30/2006	Siu M. Lee
EAST	4/27/2007	Siu M. Lee
Discuss application and amendment with Chieh Fan	4/27/2007	Siu M. Lee
EAST	10/17/2007	Siu M. Lee
Discuss the RCE with Chieh Fan	10/17/2007	Siu M. Lee
EAST	4/17/2008	Siu M. Lee
Discuss the application with Chieh Fan	4/17/2008	Siu M. Lee
EAST	12/2/2008	Siu M. Lee
Discuss the amendment with Chieh Fan	12/2/2008	Siu M. Lee
EAST	5/29/2009	Siu M. Lee
Discuss the amendment with Chieh Fan	5/28/2009	Siu M. Lee

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	132, 133, 134, 135, 136, 137	5/29/2009	Siu M. Lee
370	316, 330, 478, 132, 328, 329, 336-338, 340-342	5/29/2009	Siu M. Lee

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## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	3.01-3.04, 7, 427, 428, 12.1, 181.1, 171.1, 178.1, 186, 191.1, 456.1, 457, 414.1, 161.3, 161.3, 166.2, 184.1, 419, 345	5/29/2009	Siu M. Lee

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